Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/640,609	NAKAYAMA ET AL.	
Examiner	Art Unit	
Aung S. Mae Lin /e	2618-2622	

	SEARCHED				
Class	Subclass	Date	Examiner		
348	223.1	11/11/2006	ASM		
	224.1				
	225.1				
	228.1		V		
348	655	11/13/2006	ASM		
348	223.1	2/28/07	ιΥ		
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396	51	$\bigvee$	V		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
Interpore Search pr	nce int out	2/28/07	·	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST searched	11/11/2006	ASM		
E.A.S.T (please see search history printmet)	2/28/07	LY		
Inventorship search	2/28/07	ry		
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